

Shearography for observing defects in composite materials

- Established technique for the detection of defects in composite materials
- Cheap, relatively robust and flexible, but requires special qualification to interpret the interference pattern

Figure 1: phase difference image

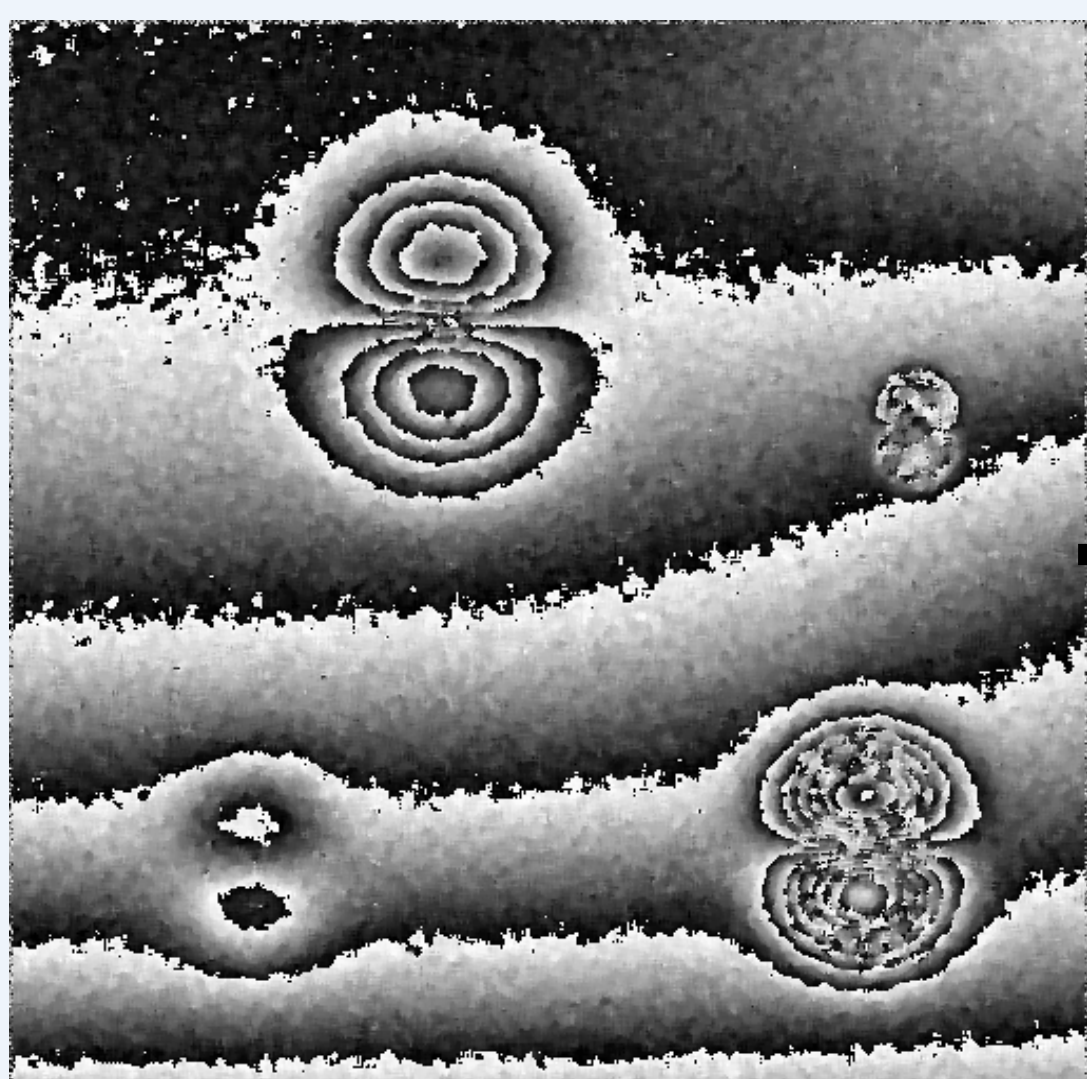


Figure 2: global gradient image

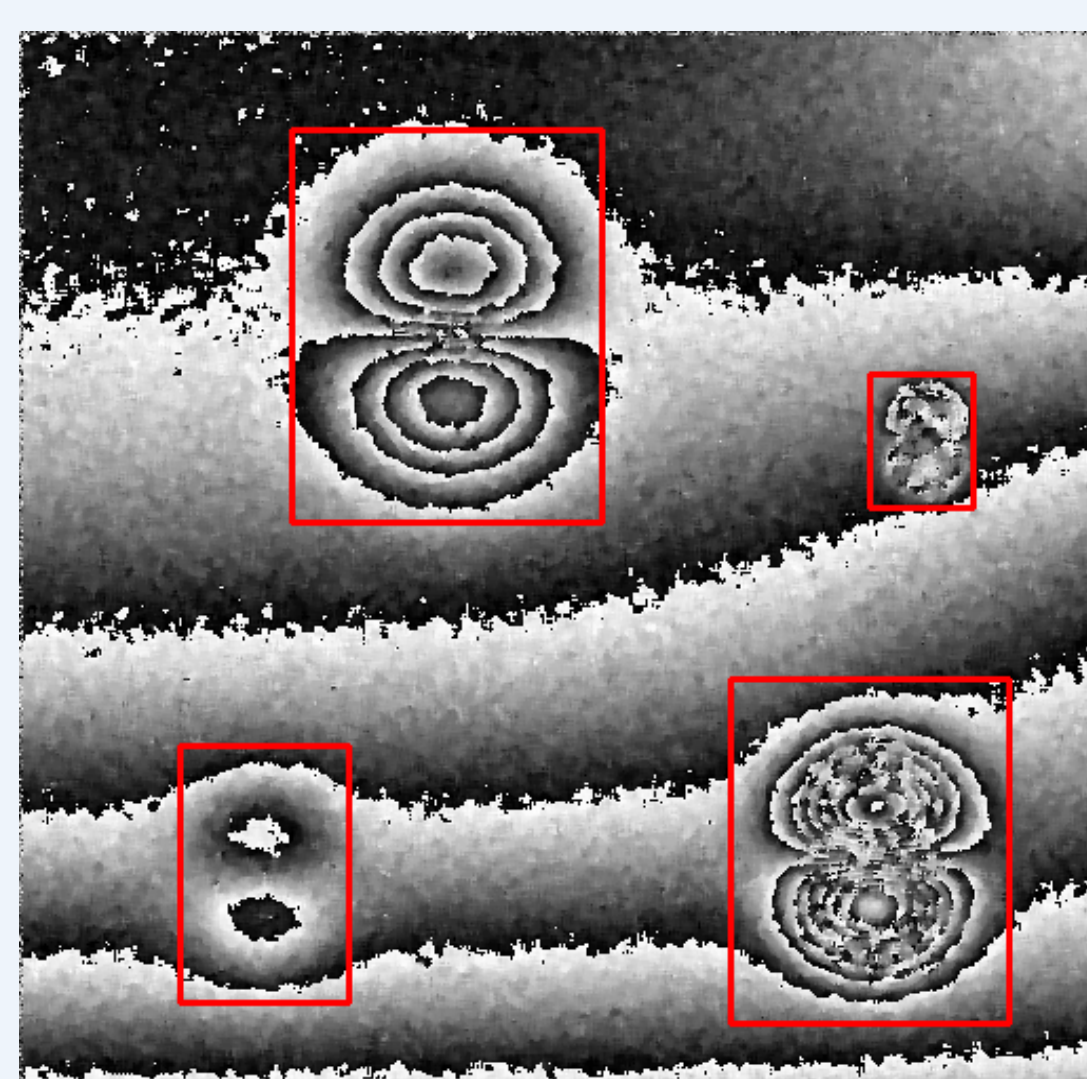
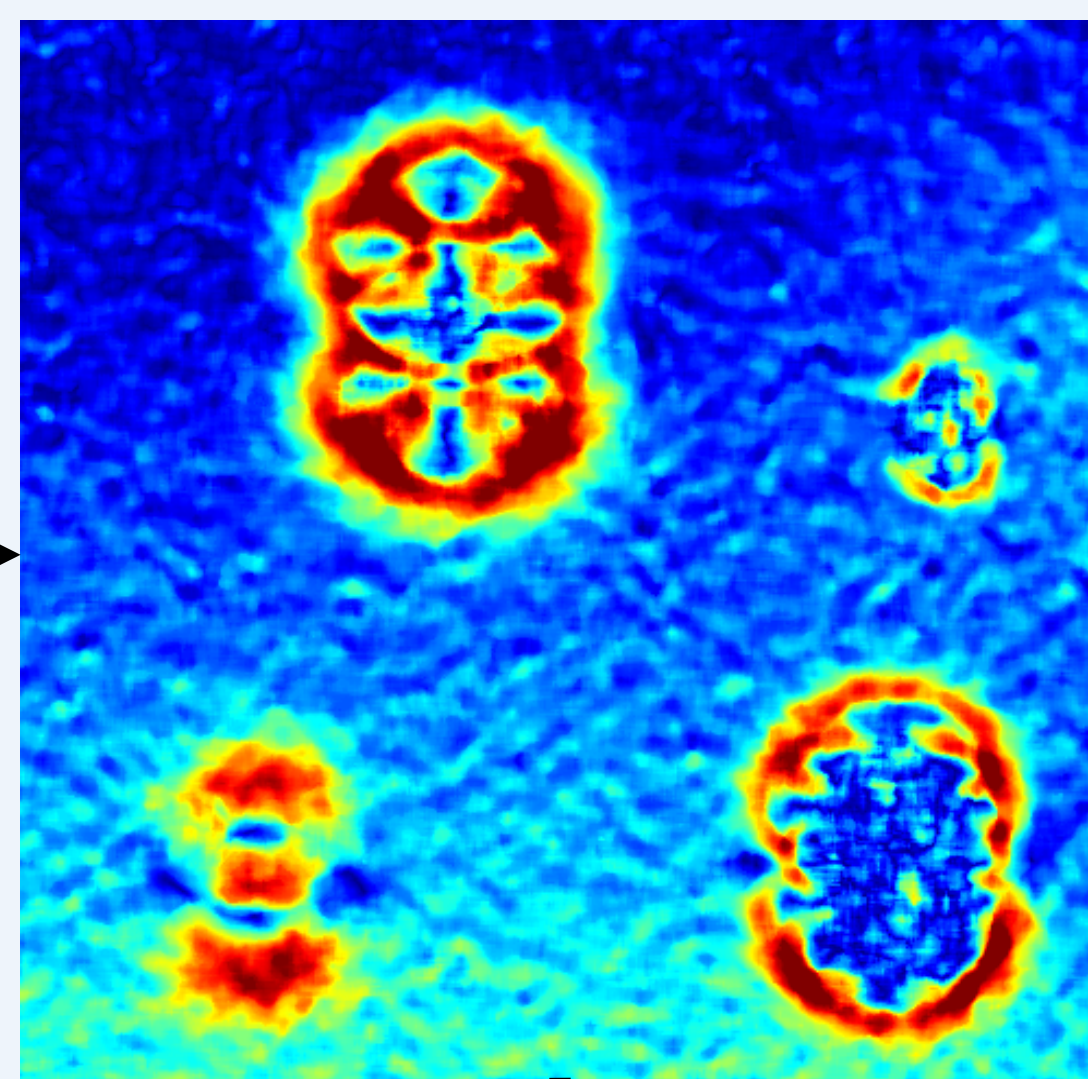


Figure 4: defects detected in the phase image

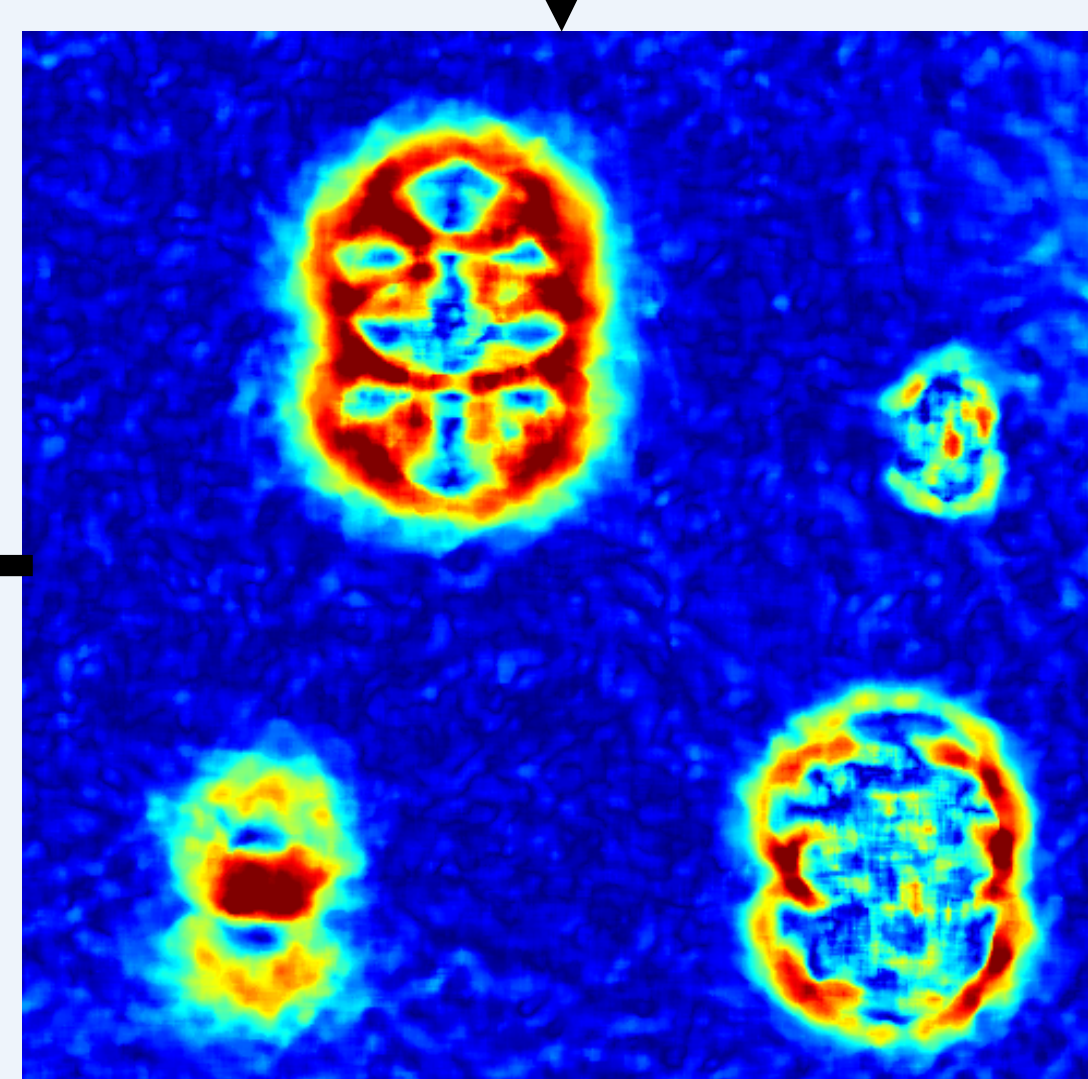


Figure 3: local gradient image

Automatically identify defects with shearography by the development of specific algorithms

- Detection of high local fringe densities
- Fringe density is correlated to phase difference slope (*i.e. the gradient of the phase difference*)

Method implemented

- Computation of the gradient from the phase image (*fig. 1 & 2*)
- Polynomial fit to remove global gradient and only observe local features (*fig. 2 & 3*)
- Detection of the defects based on the value of the local gradient above a threshold (*fig. 3 & 4*)

Improvements of the above method

- × Material with structures can show local fringe density which are not defects. They are generally smaller in size than defects.
- × Noise inherent to the speckle interferometry technique can also induce false positives, which are generally small. This noise can also make defects to be split in several smaller neighbor areas.
- To avoid these false positive, the method can be improved by setting a minimal size below which defects detected are rejected.
- To recompose the divided defects, the detected zone in contact or close vicinity are merged to recreate the real defect dimension.

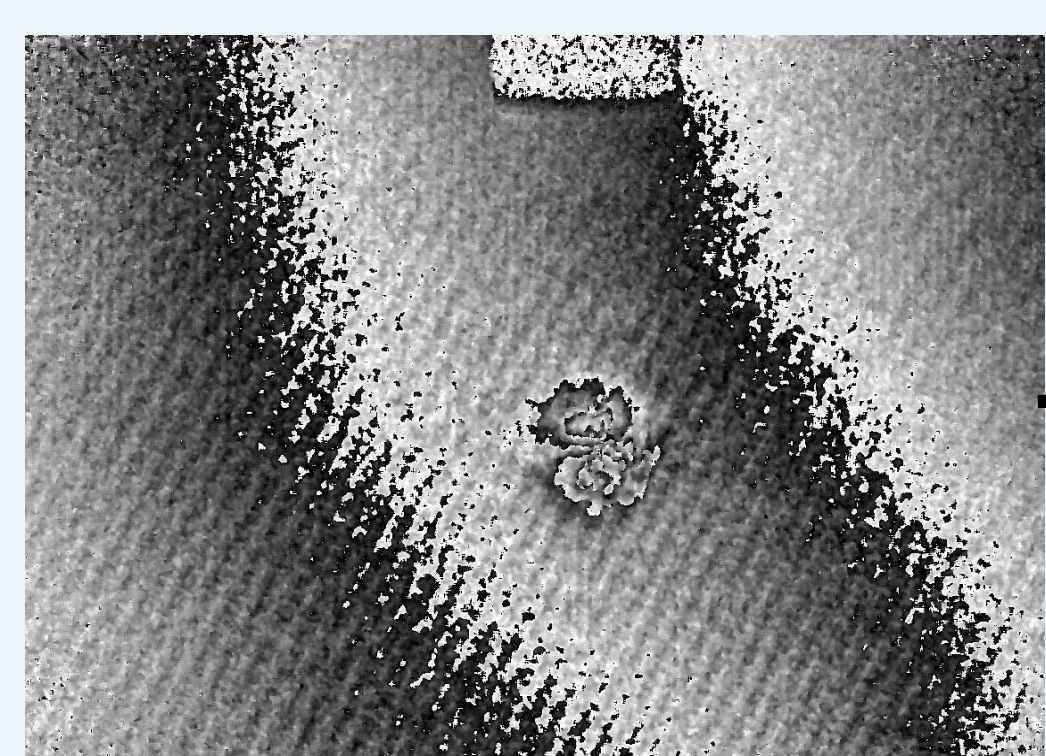


Figure 5: phase difference image

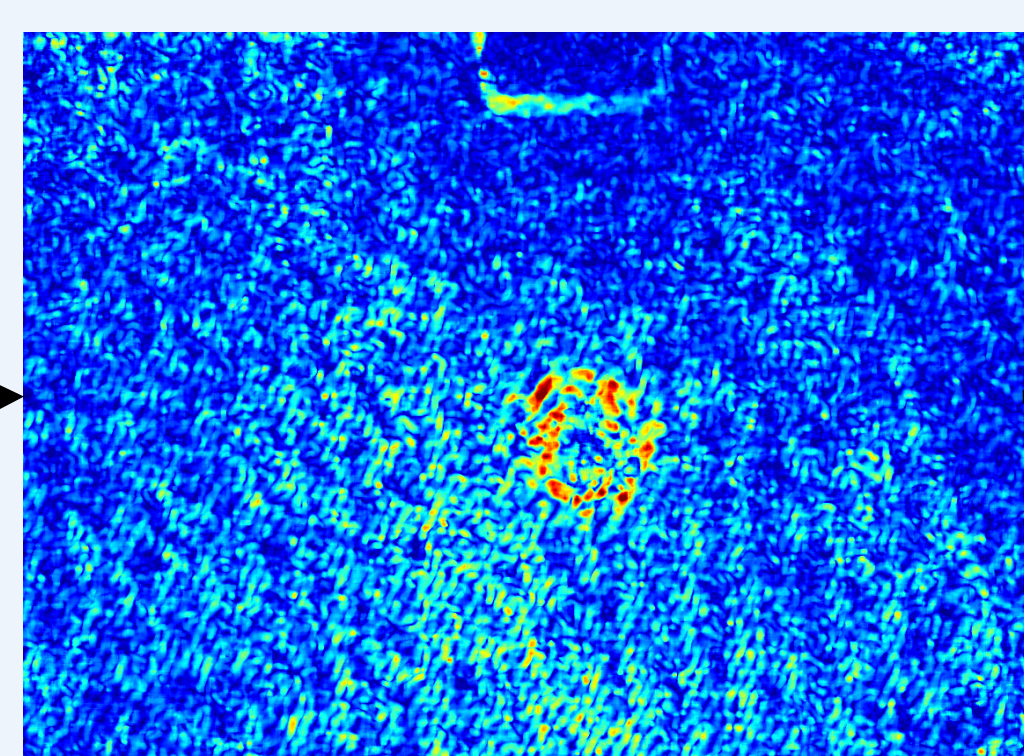


Figure 6: gradient image

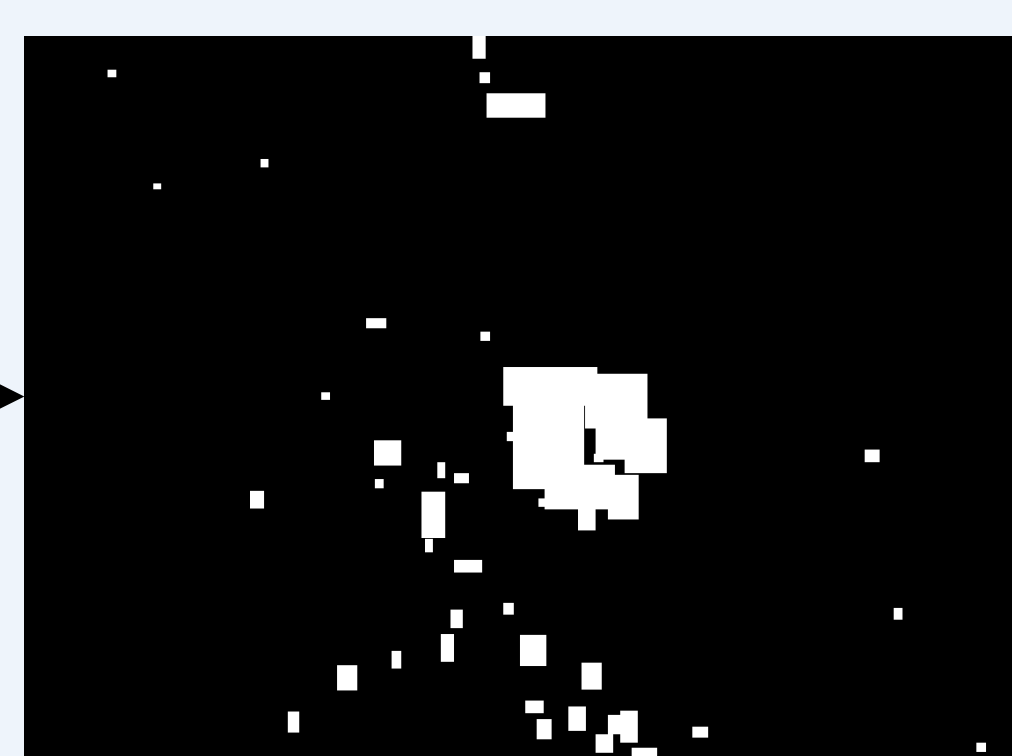


Figure 7: preliminary detection

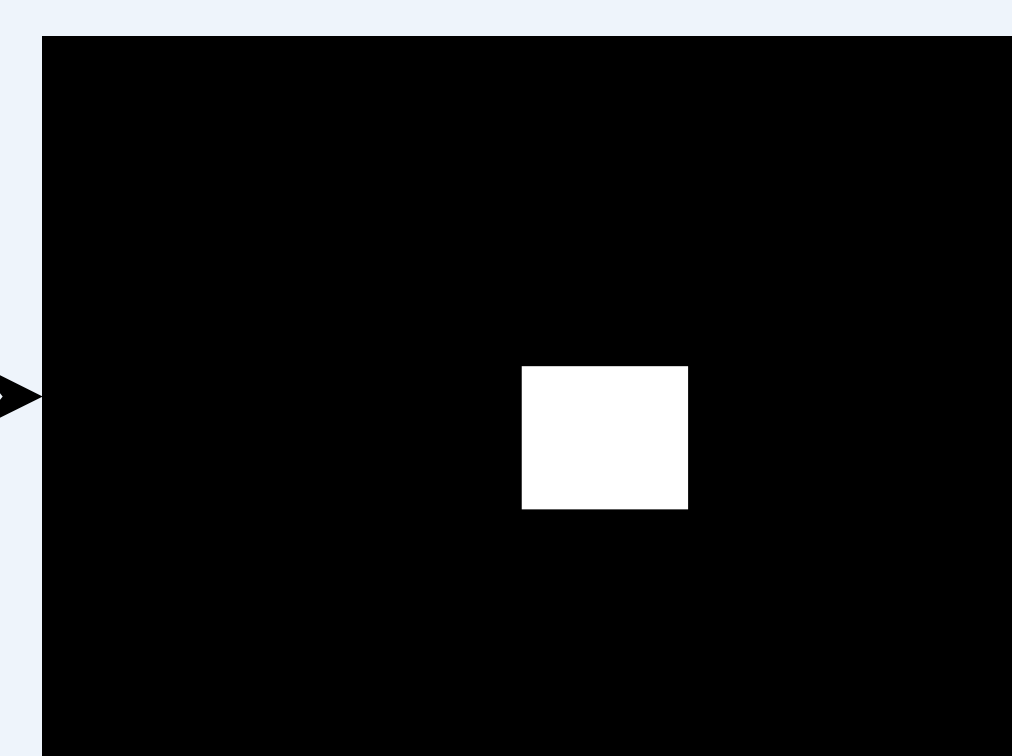


Figure 8: defects selected and merged

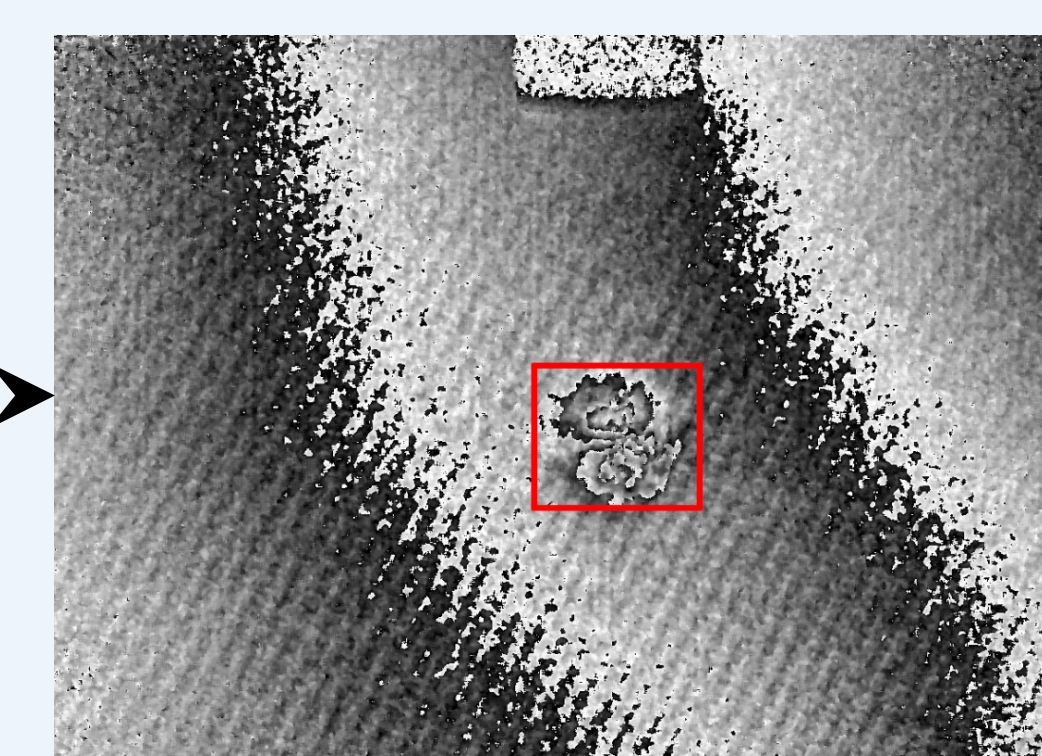
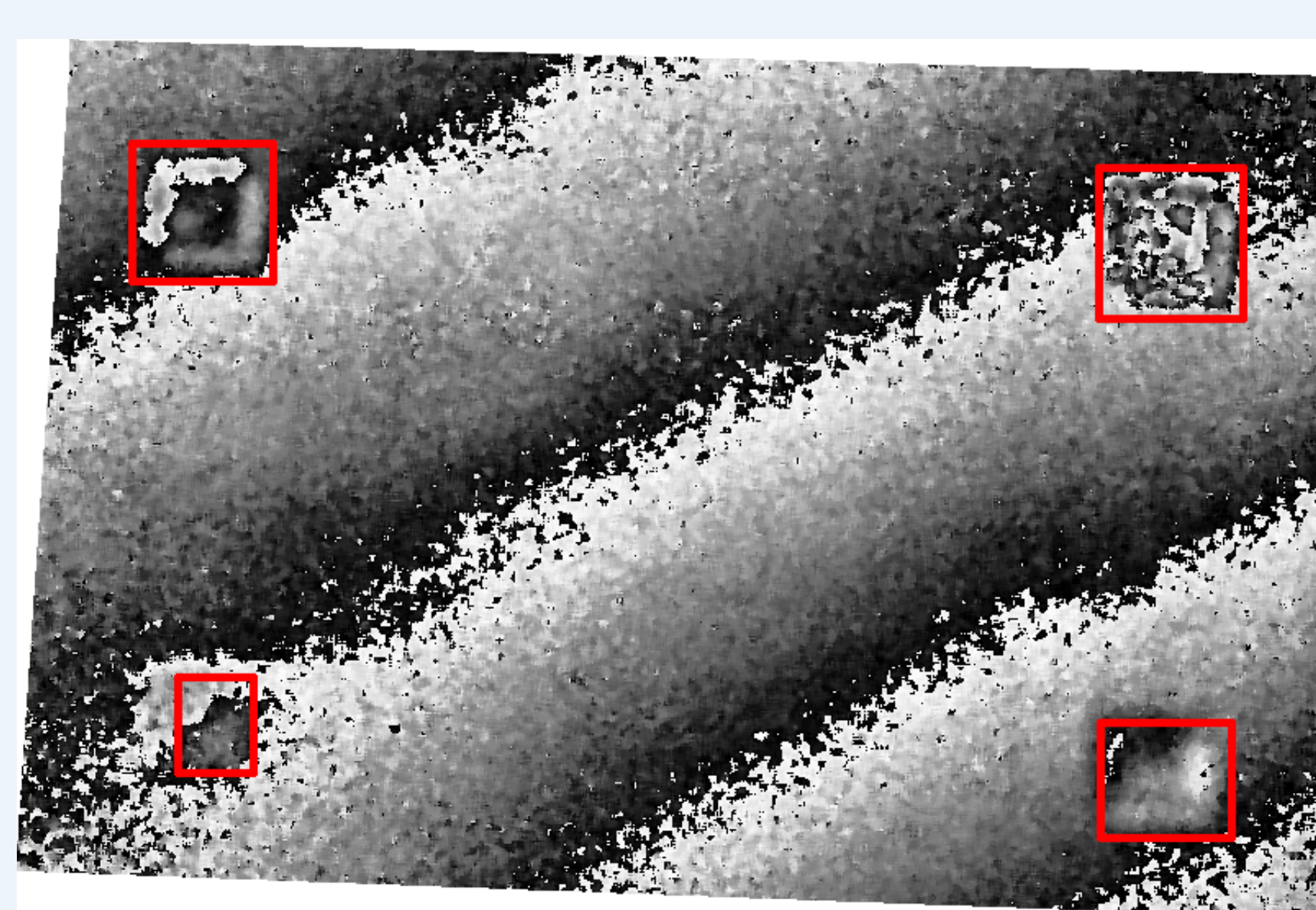
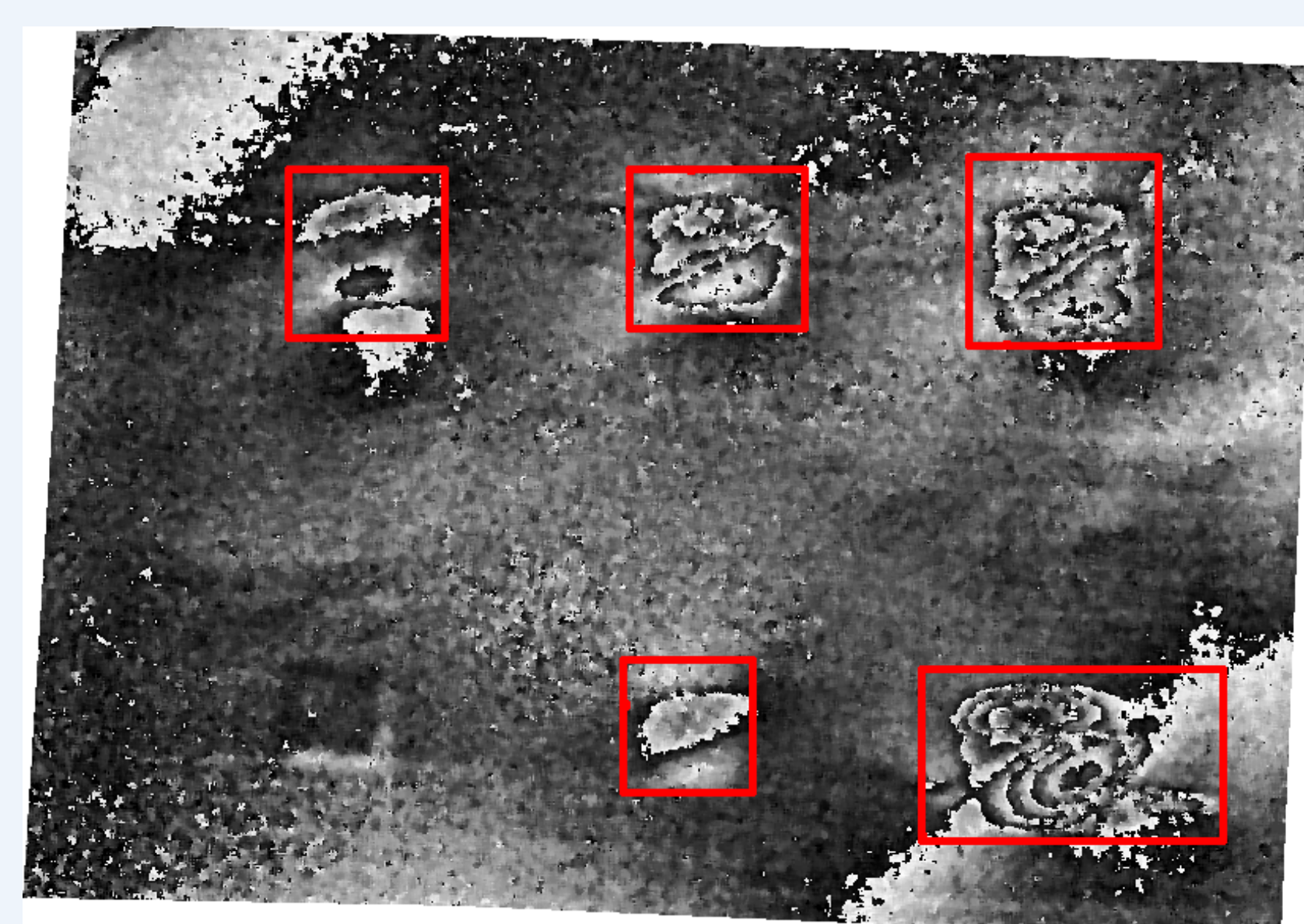


Figure 9: final output

Observation of representative samples in field conditions



Figures 10 & 11: Defects automatically detected on composite samples observed by shearography.

References

- [1] Steinchen, W (2003) Digital Shearography: Theory and Application of Digital Speckle Pattern Shearing, SPIE-International Society for Optical Engineers
- [2] Kalms, M, Osten, W(2003) Mobile shearography system for the inspection of aircraft and automotive components, Optical Engineering 42, 1188–1196
- [3] Fantin, A, Willemann, D, Viotti, M, Albertazzi, A (2013) A computational tool to highlight anomalies on shearographic images in optical flaw detection, Proc. SPIE 8788, 8788-20

Acknowledgements

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